

<b>Notice of References Cited</b>	Application/Control No. 10/729,552		Applicant(s)/Patent Under Reexamination DEEM ET AL.	
	Examiner DIANE YABUT		Art Unit 3734	Page 1 of 1

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*	B	US-6,585,144	07-2003	Adams et al.	227/175.1
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**NON-PATENT DOCUMENTS**

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